


<b>Search Notes</b> 	<b>Application/Control No.</b> 10510071	<b>Applicant(s)/Patent Under Reexamination</b> SCIAN ET AL.
	<b>Examiner</b> Zhen, Li B	<b>Art Unit</b> 2194

SEARCHED			
Class	Subclass	Date	Examiner
719	328, 331, 332	9/26/2007	LZ
717	140, 162	9/26/2007	LZ
update	search	5/22/2008	LZ
719	328, 331, 332	8/28/2008	LZ
717	140, 162	8/28/2008	LZ

SEARCH NOTES		
Search Notes	Date	Examiner
EAST (US-PGPUB;USPAT;USOCR;EPO;DERWENT;IBMTDB) See search history printout	9/26/2007	LZ
EAST (US-PGPUB;USPAT;USOCR;EPO;DERWENT;IBMTDB) See search history printout	5/28/2008	LZ
Inventor Name Search	6/4/2008	LZ
Google Search (see search history printout)	5/28/2008	LZ
EAST (US-PGPUB;USPAT;USOCR;EPO;DERWENT;IBMTDB) See search history printout	8/28/2008	LZ
Google Search (see search history printout)	8/28/2008	LZ

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
719	328, 331, 332	8/28/2008	LZ
717	140, 162	8/28/2008	LZ

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